Application/Control No. Applicant(s)/Patent Under Reexamination 10/609,477 ENDO ET AL. **Notice of References Cited** Art Unit Examiner Page 1 of 1 TAN X. DINH 2627 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-7,187,627 b2 03-2007 Nonaka et al. 369/30.05 04-2003 369/30.19 US-6,556,518 b2 Isobe et al. В US-С US-D US-Ε US-US-G US-Н US-USj

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